

Product Bulletin

Document # : PB20911X Issue Date: 2 June 2015

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Title of Change:	Datasheet correction for CAT4109/CAV4109 series, ESD rating	
Effective Date:	Effective Immediately	
Contact information:	Contact your local ON Semiconductor Sales Office or <shannon.riggs@onsemi.com></shannon.riggs@onsemi.com>	
Type of notification:	ON Semiconductor considers this change approved unless specific conditions of acceptance are provided in writing. To do so, contact <pcn.support@onsemi.com>.</pcn.support@onsemi.com>	
Change category(s): Wafer Fab Change Assembly Change Test Change	☐ Manufacturing Site Change/Addition☐ Manufacturing Process Change☐ Material Change	 □ Product specific change □ Datasheet/Product Doc change □ Shipping/Packaging/Marking □ Other:
Sites Affected: ☐ All site(s) ☐ not applicable ☐ ON Semiconductor site(s): ☐ External Foundry/Subcon site	e	Site 2
Description and Purpose:		
An error was identified in the ESD rating listed on datasheet CAT4109/D, revision 5 from January 2015. In order to correct this error, the change below has been made on the document. This change is the result of a documentation error only; there is no change to the current product form, fit, or function. ESD RATING		
Human Body Model (Note 2) LV pins (non LEDn pins # 3, 4, 5, 6, 7, 8, 15 and 16) HV pins(LEDn pins #9, 10 and 11)		1500 -750 500
Machine Model (Note 3) LV pins (non LEDn pins # 3, 4, 5, 6, 7, 8, 15 and 16) HV pins (LEDn pins #9, 10 and 11)		200 175
Charged Device Model (Note 4)		1000 V
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 2. JESD22-A114C 3. JESD625-A 4. JESD22-C101E		
List of Affected Standard Parts: CAT4109V-GT2 CAV4109V-GT2		

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